

<b>Search Notes</b>  <b>*1065029</b>  <b>8*</b>	<b>Application/Control No.</b>  10650298	<b>Applicant(s)/Patent Under Reexamination</b>  DESAI ET AL.
	<b>Examiner</b>  GERMAN VIANA DI PRISCO	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
See application file for complete search history		3/24/2010	GV

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	8/31/2008	GV
Inventor name and Assignee search in PALM ExPO and EAST	8/31/2008	GV
Consulted with Rafael Perez-Gutierrez	8/31/2008	GV
Updated search	3/24/2010	GV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
See interference search in search history		3/24/2010	GV

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